

Econometrics on Networks

Special Quarter: Data Science & Online Markets

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Introduction

Ising Model

Given a graph $G = (V, E)$ whose nodes are associated with external field $(\theta_u)_{u \in V}$ and edges with parameters $(\theta_{u,v})_{(u,v) \in E}$, the Ising model defines a probability distribution over $x \in \{\pm 1\}^n$

PDF of Ising model

$$p(x) = \frac{1}{Z(\theta)} \cdot \exp \left(\sum_i \theta_i x_i + \sum_{(i,j)} x_i x_j \theta_{i,j} \right)$$

θ_i on each vertex is also known as external fields.

Problem 1 : Approximating Ising Distribution

Problem setup

- Unknown Graph
- Polynomial samples from the stationary distribution
- No external fields
- $\theta_{ij}^* > 0 \quad \forall i, j$
- Goal: Recover an Ising model whose distribution is close in TV distance (or SKL) to the Ising distribution sampled from.

Motivation: Lower bounds to recover the graph

- Given i.i.d samples x_1, \dots, x_N , ideally, we would like to recover the graph structure and the associated edge weights.

Motivation: Lower bounds to recover the graph

- Given i.i.d samples x_1, \dots, x_N , ideally, we would like to recover the graph structure and the associated edge weights.
- However, there is a information-theoretic lower bound - we need atleast $O(\exp(d))$ samples, where d is the maximum degree. See [Santhanam and Wainwright, 2012]

Problem Objective

This calls for a relaxation of our original goal. Can we instead just find an approximation of the original Ising distribution $p^*(x)$, i.e find another Ising model whose distribution $p(x)$ satisfies $SKL(p||p^*) \leq \epsilon$, where SKL refers to symmetric KL divergence. Such a goal comes under *proper learning*.

Symmetric KL Divergence

$$\begin{aligned} SKL(p||p^*) = & \sum_{i \in V} (\theta_i - \theta_i^*) (\mathbb{E}_p[x_i] - \mathbb{E}_{p^*}[x_i]) \\ & + \sum_{(i,j)} (\theta_{ij} - \theta_{ij}^*) (\mathbb{E}_p[x_i x_j] - \mathbb{E}_{p^*}[x_i x_j]) \leq \epsilon \end{aligned}$$

Sufficient condition

Sufficient condition:

Ignoring external fields, the following simple condition that $\forall ij \in E, |\theta_{ij} - \theta_{ij}^*| \leq \frac{\epsilon}{n^2}$ guarantees that $SKL(p||p^*) \leq \epsilon$

A recent paper by [Klivans and Meka, 2017] addresses this problem.

Approach: They pose the problem as learning a generalized linear model (GLM): Given Ising samples with conditional mean functions of the form $P(x_v | x_{-v}) = \sigma(\vec{\theta}_{-v}^* \cdot x_{-v})$, we want to recover $\vec{\theta}_{-v}^*$ for all v .

Algorithm: Their algorithm termed *Sparsitron* is based on multiplicative updates method but uses a novel loss function. This method is used to achieve small squared loss and a further assumption that the given Ising model is δ -unbiased makes strong recovery (parameters) possible.

Results: To achieve $\|\theta - \theta^*\|_\infty \leq \frac{\epsilon}{n^2}$, they require:

Sample-complexity: $N = O(n^8 \lambda^2 \exp(\lambda) / \epsilon^4) \cdot (\log(n^3 / \rho \epsilon))$, where λ upper bounds $\|\theta_v^*\|_1$ for all v and ρ is the probability of failure.

In the high-temperature regime, under the assumption that $\|\theta_v^*\|_1 = 1$ for all v , this effectively gives $\tilde{O}\left(\frac{n^8}{\epsilon^4}\right)$

However, information-theoretically, finding a SKL approximation only requires $O(n^2 / \epsilon^2)$ samples in the high-temperature regime

Can we do better?

Our approach: Logistic Regression

For a given vertex v , the marginal distribution given all the other labels x_{-v} is

$$p(x_v | \vec{\theta}_v, x_{-v}) = \frac{\exp(\sum_{u, u \neq v} \theta_{v,u} \cdot x_u \cdot x_v)}{\exp(\sum_{u, u \neq v} \theta_{v,u} \cdot x_u \cdot x_v) + \exp(-\sum_{u, u \neq v} \theta_{v,u} \cdot x_u \cdot x_v)}$$

Hence if we have N iid samples, and if $\vec{x}_v \in \{\pm 1\}^N$ is the labels for v , and $X_{-v} \in \{\pm 1\}^{n-1 \times N}$

Likelihood

$$L_v(\vec{\theta}_v) = p(\vec{x}_v | \vec{\theta}_v, X_{-v}) = \prod_{i=1}^N \frac{\exp(2 \sum_{u, u \neq v} \theta_{v,u} \cdot x_u^{(i)} \cdot x_v^{(i)})}{1 + \exp(2 \sum_{u, u \neq v} \theta_{v,u} \cdot x_u^{(i)} \cdot x_v^{(i)})}$$

Which would serve as the likelihood function for logistic regression.

Negative log-likelihood minimization

Just like in logistic regression, we perform negative log likelihood (NLL) minimization

Negative log likelihood

$$NLL_v(\vec{\theta}_v) = -2 \sum_{i=1}^N x_v^{(i)} \vec{\theta}_v^T X_{-v}^{(i)} + \sum_{i=1}^N \log(1 + \exp(2x_v^{(i)} \vec{\theta}_v^T X_{-v}^{(i)}))$$

Gradient

$$\nabla NLL = -2X_{-v}(I - D)x_v$$

where D is a diagonal matrix with $D_{i,i} = \frac{\exp(2x_v^{(i)} \vec{\theta}_v^T X_{-v}^{(i)})}{1 + \exp(2x_v^{(i)} \vec{\theta}_v^T X_{-v}^{(i)})}$

Hessian

$$\nabla^2 NLL = X_{-v} D' X_{-v}^T$$

where D' is a diagonal matrix with $D'_{i,i} = \frac{4e^{2x_v^{(i)} \bar{\theta}_v^T X_{-v}^{(i)}}}{\left(1 + e^{2x_v^{(i)} \bar{\theta}_v^T X_{-v}^{(i)}}\right)^2}$

Notice that this is a PSD matrix and thus, the objective is convex. This allows us to exploit convex optimization tools (aka Gradient Descent).

Technical Questions

- Understanding spectral properties of the Hessian so as to check for strong convexity and smoothness. This might be of independent interest.
- Under what conditions is the NLL objective function Lipschitz?
- Study how minimizing the NLL objective might give us strong recovery guarantees in the parameter space.
- What set of assumptions about the temperature and the underlying graph are needed for the above?
- How does regularization help?

Problem 2 : Learning the sign from one sample

Problem setup

- Unknown Graph
- One sample
- No external fields
- $\theta_{ij} = \theta \quad \forall i, j$ i.e. edge parameter is the same for all edges.
- Goal: Recover the sign of θ

Can't do it for general Graphs (even with constant probability)

For example :

- Star Graph $K(1, n)$
- Complete Bipartite Graph where one side is constant sized : $K(c, n)$
- Path on cliques

We can learn on $K(n, n)$ graphs!

Approaches and Experiments

Given these results : Try to solve the problems on restricted graph classes.

Idea 1 : $G(n, p)$ graphs.

Idea 2 : Graphs that are 'well connected'.

Motivation : If there are a lot of pieces of the graph that don't interact much with each other, then $|\sum_{i=1}^n X_i|$ is close to zero in both cases $\theta > 0$ and $\theta < 0$. For example a path of cliques.

Preliminary Experiments

In random $G(n, p)$ graphs, for $\theta < 0$, $\sum X_i$ is close to zero and for $\theta > 2/np$, $|\sum X_i|$ is close to n .

As a possible explanation, $\theta \leq 1/np$ is the 'high temperature' regime or Dobrushin's condition is satisfied. There might be a transition behaviour at this point.

Random Cluster(FK) model

- Introduced by Fortuin and Kastelyn, for $\theta > 0$, this is another way of sampling from the Ising model.
- Sample a subset $S \subseteq E$ of edges of the input graph G with probability proportional to

$$p^{|S|}(1-p)^{|E|-|S|}q^{k(S)}$$

where $k(S)$ is the number of connected components in (V, S) .

- Assign each connected component a label uniformly at random from $1 \dots q$.
- They prove, this distribution is exactly same as the Potts model for q states. Specifically for $q = 2$ this is exactly the Ising distribution.

Using the FK model : Further Approaches

For the restricted classes of graphs mentioned above :

- Prove a lower bound on the size of the largest component.
- Prove that the other components are somewhat small.
- Conclude that in expectation, $|\sum X_i|$ size of largest component.
- Conclude separately that for $\theta < 0$, $|\sum X_i|$ is close to zero. (Some preliminary experimental and theoretical evidence suggesting this.)
- Deduce sign of θ depending on whether $\sum X_i$ is small or large.

Problem 3 : Logistic Regression on Networks

Ising model and features

- Graph $G(V, E)$ with $n \times n$ adjacency matrix A (Known).

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Given an assignment $\vec{\sigma} : V \rightarrow \{-1, +1\}$, we define the following probability distribution (on the 2^n configurations):

$$\Pr[\tau = \sigma] = \frac{\exp\left(\sum_{v \in V} (\vec{\theta}^\top \cdot \vec{y}_v) \sigma_v + \beta \vec{\sigma}^\top A \vec{\sigma}\right)}{Z(G)} \quad (1)$$

where $Z(G)$ is the partition function of the system (i.e., the renormalization factor).

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Problem: We would like to infer $\vec{\theta}, \beta$

Naive approach for bounded degree (Δ) graphs

- Find an **independent set** I of size at least $\frac{n}{\Delta}$.

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- To infer β, θ , we reduce the problem to classic **logistic regression** (independent “samples”). $\vec{\theta}$ can be inferred but the signal for β might be **lost**.

Main challenges!

- Go beyond bounded degree graphs (dense).

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- Use the information from all the vertices.
- Beat the $\sqrt{\frac{\Delta}{n}}$ consistency that will occur.

Questions?

Thank You!



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